

EMI TEST REPORT

FCC PART 15 CLASS B

for

ATEC SYSTEM CO., LTD.

**#1451-78, Seocho-Dong, Seocho-Gu,
Seoul, 137-867,
KOREA**

on the

LCD MONITOR

AL170

FCC ID: PDLAL170

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Prepared By:

Test Date: Jun 25, 2003

Test Engineer: Y. Choi

Printed Name

young choi
Signature

Compliance Engineer: H. S. Lee

Printed Name

Hyung-Sung, Lee
Signature



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Testing Laboratories for EMC and Safety Compliance

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Table of Contents

1	General Information	
1.1	Introduction	3
1.2	Product Description for Equipment Under Test (EUT)	3
1.3	Equipment Under Test	4
1.4	Host System Configuration	4
1.5	External I/O Cabling	4
1.6	Special Accessories	4
1.7	EUT Modifications	5
1.8	Configuration of Test System	5
2	Test Performed	
2.1	Conducted Emission Measurements	6
2.1.1	Test Description	6
2.1.2	Test Equipments	6
2.1.3	Test Environments	6
2.1.4	Test Limits	6
2.1.5	Test Exercise Program	6
2.1.6	Test Procedure	6
2.1.7	Test Configuration	7
2.1.8	Test Results	7
2.1.9	Test Data	7
2.1.10	Plots of Test Data	8
2.2	Radiated Emission Measurements	9
2.2.1	Test Description	9
2.2.2	Test Equipments	9
2.2.3	Test Environments	9
2.2.4	Test Limits	9
2.2.5	Test Exercise Program	9
2.2.6	Test Procedure	10
2.2.7	Field Strength Calculation	10
2.2.8	Test Configuration	10
2.2.9	Test Results	11
2.2.10	Test Data	11

Table of Contents(cont'd)

3	Product Labelling Requirements	
3.1	FCC ID/Statement	12
3.2	Label Location	12
4	Test Setup Photographs	
4.1	Conducted Emission: Front View	13
4.2	Conducted Emission: Rear View	13
4.3	Radiated Emission: Front View	14
4.4	Radiated Emission: Rear View	14
5	External Photographs	
5.1	EUT: Front View	15
5.2	EUT: Rear View	15
5.3	EUT: Label View	16
5.4	EUT: Internal View	16
6	Internal Photographs	
6.1	EUT: Main Board, Component View	17
6.2	EUT: Main Board, Circuit View	18
6.3	EUT: Inverter Board, Component View	19
6.4	EUT: Inverter Board, Circuit View	20
	Appendix A Schematics/Block Diagram	21
	Appendix B User's Manual	22

1. General Information

1.1 Introduction

The EMI Test Report of Information Technology Equipment is prepared on behalf of named applicant in accordance with the ANSI C63.4-1992. The test results reported in this document relate only to the item that was tested.

The detailed description of the measurement facility was found to be in compliance with the requirement of Section 2.948 of the FCC Rules. The Federal Communications Commission has the reports on file and is listed under Registration Number 100384. The scope of the accreditation covers the FCC Method - 47 CFR Part 15 or 18 of the Commission's Rules.

All measurements contained in this report were conducted in accordance with ANSI C63.4-1992. The instrumentation utilized for the measurements conforms with CISPR16 Specification for Radio Disturbance and Immunity Measuring Apparatus and Methods. Some accessories are used to increase sensitivity and prevent overloading of the measuring instrument. Calibration checks are performed yearly on the instruments by a local calibration laboratories.

All radiated and conducted emission measurements are performed manually at Korea Standard Quality Laboratories (hereinafter referred to as "KSQLab"), #102, Jangduk-Dong, Hwasung-Shi, Kyunggi-Do, KOREA. The radiated emission measurements required by the FCC Rules were performed on 3 meter or 10 meter, Open Area Test Site, test range maintained by KSQLab. Complete ANSI 63.4-1992 description and site attenuation measurement data records are maintained at the test facility and have been placed on file with the Federal Communications Commission. The power line conducted emission measurements were performed in a shielded enclosure also located at the same facility. The KSQLab EMC test facility in Hwasung-Shi are designated testing laboratory according to ISO/IEC 17025 by Radio Research Laboratory (RRL), Ministry of Information and Communication.

1.2 Product Description for Equipment Under Test (EUT)

Main Specification of ATEC SYSTEM CO., LTD.'s LCD MONITOR, Model No: AL170, are:

- ◆ LCD Panel Type : a-Si active matrix TFT-LCD
 - Size : 17.0"(459,74 mm)
 - Pixel Pitch : 0.264 mm x 0.264 mm
 - Color depth : 8 bit(16,777, 216 colors)
- ◆ Video Signal : 1280 x 1024(Recommended Resolution)
 - H freq. : 31.5~ 80 KHz, V freq. : 56 ~75 Hz
- ◆ Speaker : Stereo 2 Watt x 2
- ◆ Signal Input : 15pin D-Sub
- ◆ Power : DC12V, 3.3A from AC/DC Adapter
- ◆ Size of Monitor(W x D x H) : 379.6 x 169.9 x 395 mm

EMI TEST REPORT



Report Number : KSQ-FCC030627

FCCID : PDLAL170

1.3 Equipment Under Test

Description	Model Number	Serial Number	Manufacturer	Remarks
LCD MONITOR	AL170	none	ATEC SYSTEM CO., LTD.	EUT
POWER SUPPLY	LSE9901B1250	A20310000497	Lishin International Enterprise Corp.	AC/DC Adapter

1.4 Host System Configuration

Description	Model Number	Serial Number	Manufacturer	Remarks
Host Computer	TH-1000	none	Hanmi I&C Co., Ltd.	ATX
Keyboard	SEM-DT35	22022689	Samsung Electro-Mecha	PS/2
Mouse	76FSERIAL9D	1005213	Microsoft Corp.	Serial
Printer	6XU2225C	3037S84200	Hwelett Packard	Inkjet
PC Camera	PCC2200	PK2-0020	Pro-chips	USB
Joystick	DHA-2000	none	Dahwoon Electronics	-
Speaker	GL-2000	none	Comsources	-
Microphone	JPM601	none	Hi-sonic	-

1.5 External I/O Cabling

Description	Length (m)	Port/From	Port/To	Remarks
Video Cable	1.5	Dsub/Host	EUT	Shielded
Keyboard Cable	2.0	PS2/Host	Keyboard	Shielded
Mouse Cable	2.0	Dsub/Host	Mouse	Shielded
Printer Cable	1.5	Dsub/Host	Printer	Shielded
USB Cable	2.0	USB/Host	PC Camera	Shielded
Joystick Cable	1.5	Dsub/Host	Joystick	Shielded
Audio Cable	1.0	Jack/Host	Audio In/EUT	Shielded
Speaker Cable	1.0	Audio Out/EUT	Speaker	Shielded
Microphone Cable	2.0	Jack/Host	Microphone	Shielded

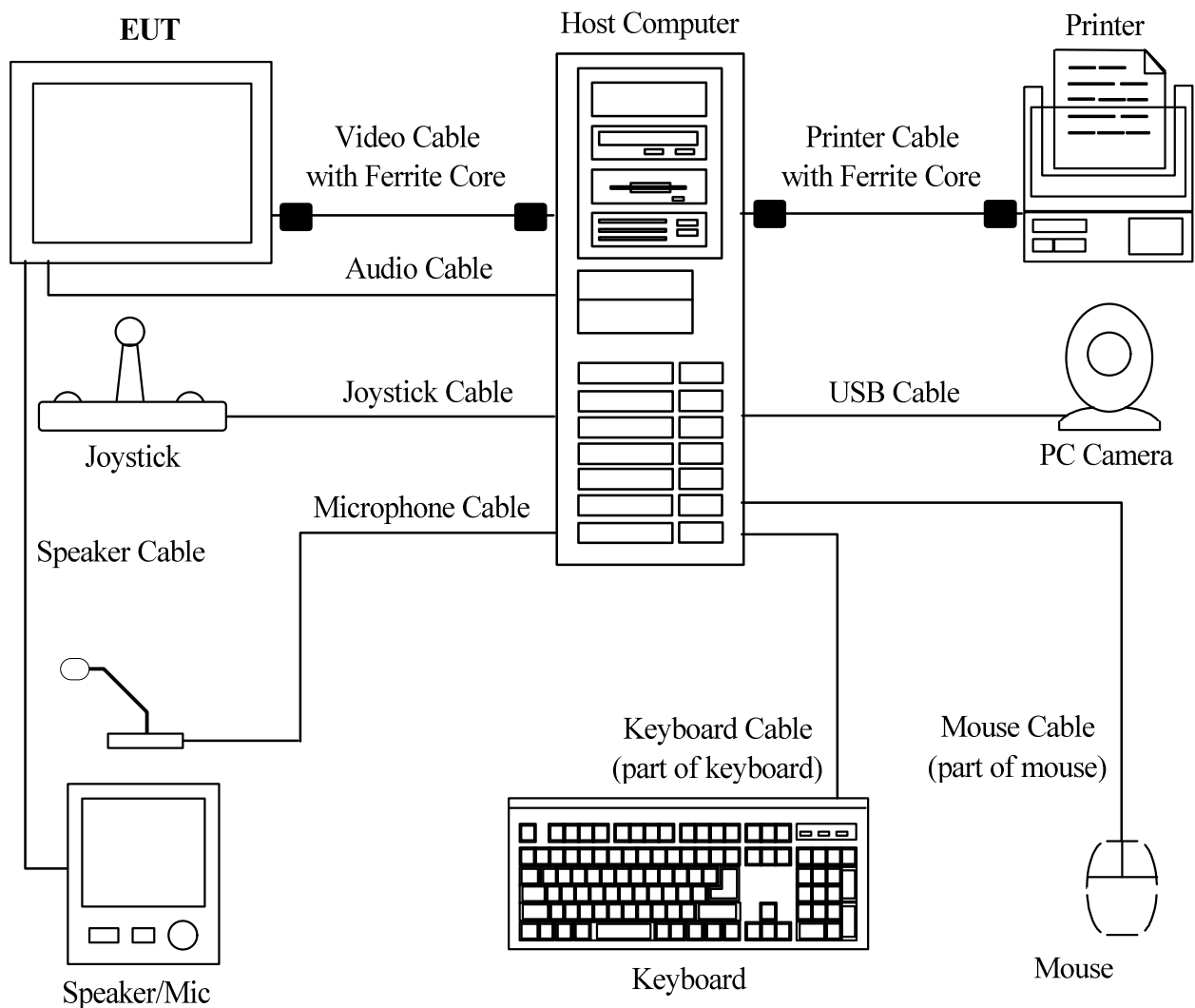
1.6 Special Accessories

As shown in section 1.8, all interface cables used for compliance testing are shielded as normally supplied or by use respective component manufacturers.

1.7 EUT Modifications

No modifications were made to the EUT in order to achieve and maintain compliance to the standards described in this report.

1.8 Configuration of Test System



2. Test Performed

2.1 Conducted Emission Measurements

2.1.1 Test Description

The power line conducted emission measurements were performed in a shielded enclosure, using the setup in accordance with ANSI C63.4-1992 conducted emission measurement procedure.

2.1.2 Test Equipments

Description	Manufacturer	Model Number	Serial Number	Cal. Due
Spectrum Analyzer	Advantest	3261A	21720240	10, 2003
LISN1	Electro Metrics	ANS-25/2	2535	10, 2003
LISN2	Kyoritsu	KNW-407	8-1010-14	10, 2003
Plotter	Hewlett Packard	7550B	3050A14513	n/a

2.1.3 Test Environments

Ambient Temperatures	Relative Humidity
15~35 °C	30~60 %

2.1.4 Test Limits

Frequency (MHz)	CISPR22 Limits			
	Class B (dBuV)		Class A (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 to 0.50	66.0 to 56.0	56.0 to 46.0	79.0	66.0
0.50 to 5.00	56.0	46.0	73.0	60.0
5.00 to 30.00	60.0	50.0	73.0	60.0

2.1.5 Test Exercise Program

Please refer to section 2.2.5 for the test exercise program.

2.1.6 Test Procedure

Conducted emission levels were measured on each current-carrying line with the spectrum analyzer operating in the CISPR quasi-peak mode (or peak mode if applicable). The analyzer's 6dB bandwidth was set to 9kHz. The initial step in collecting conducted data is a spectrum analyzer peak scan of the measurement range. If the conducted emission exceed the average limit with the instrument set to the quasi-peak mode, the measurements are made in the average mode. The emission spectrum was scanned from 150kHz to 30MHz. The highest emission amplitudes relative to the appropriate limits were measured and have been recorded. Quasi-peak readings are distinguished with a "QP". The conducted emission test was performed with the EUT exercise program loaded, and the emissions were scanned between 150kHz to 30MHz on the HOT side and NEUTRAL side, herein referred to as H and N, respectively.

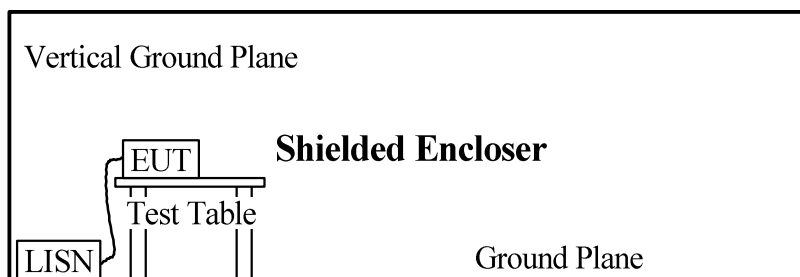
EMI TEST REPORT



Report Number : KSQ-FCC030627

FCCID : PDLAL170

2.1.7 Test Configuration



2.1.8 Test Results

According to the data in section 2.1.9, the EUT complied with the CISPR22 limits, and had the worst margin reading of:

-13.8dB at 2.79MHz in the HOT side.

2.1.9 Test Data

Line Conducted Emission				CISPR22 Class B		
Frequency (MHz)	Amplitude (dBuV)	Phase Hot/Neutral	Detector QP/AV/PK	Applicable Limit		Margin (dB)
				QP (dBuV)	AV (dBuV)	
0.15	46.1	N	PK	66.0	56.0	-19.9
0.17	45.9	N	PK	65.5	55.5	-19.6
0.18	44.6	N	PK	65.0	54.5	-20.4
0.22	40.0	N	PK	63.6	52.8	-23.6
0.30	34.9	H	PK	63.2	50.2	-28.3
0.34	33.2	H	PK	62.1	49.2	-28.9
0.60	38.0	H	PK	56.0	46.0	-18.0
1.47	40.7	H	PK	56.0	46.0	-15.3
2.02	41.7	N	PK	56.0	46.0	-14.3
2.25	41.5	H	PK	56.0	46.0	-14.5
2.79	42.2	H	PK	56.0	46.0	-13.8
3.10	39.9	H	PK	56.0	46.0	-16.1
7.28	37.6	H	PK	60.0	50.0	-22.4
9.02	37.2	N	PK	60.0	50.0	-22.8
9.22	41.9	N	PK	60.0	50.0	-18.1
9.99	41.5	H	PK	60.0	50.0	-18.5
10.01	39.0	H	PK	60.0	50.0	-21.0
10.05	35.5	H	PK	60.0	50.0	-24.5

Temperature: 24 °C Humidity: 45 % Test Date: Jun 25, 2003 Tested by: Y. Choi

EMI TEST REPORT

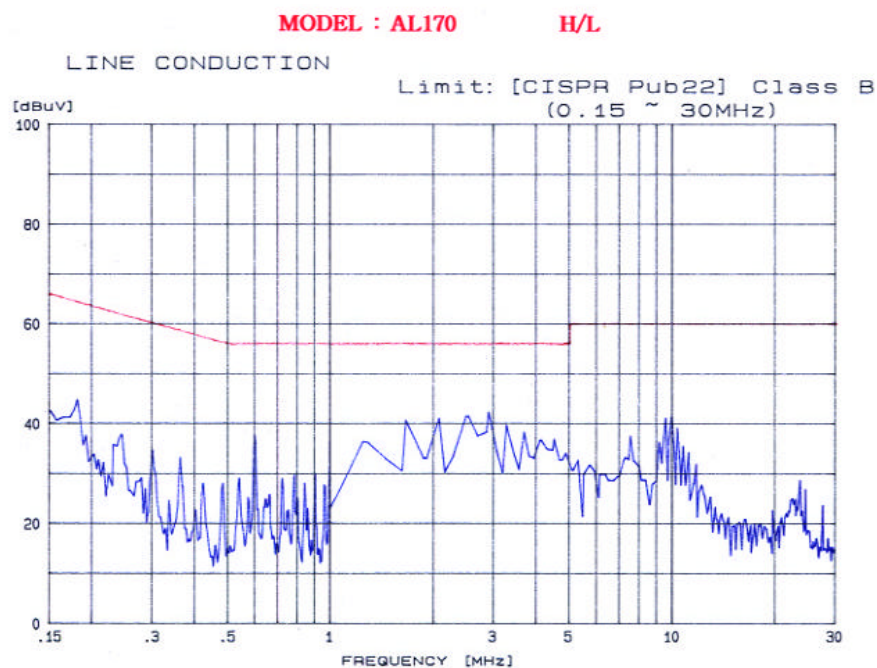


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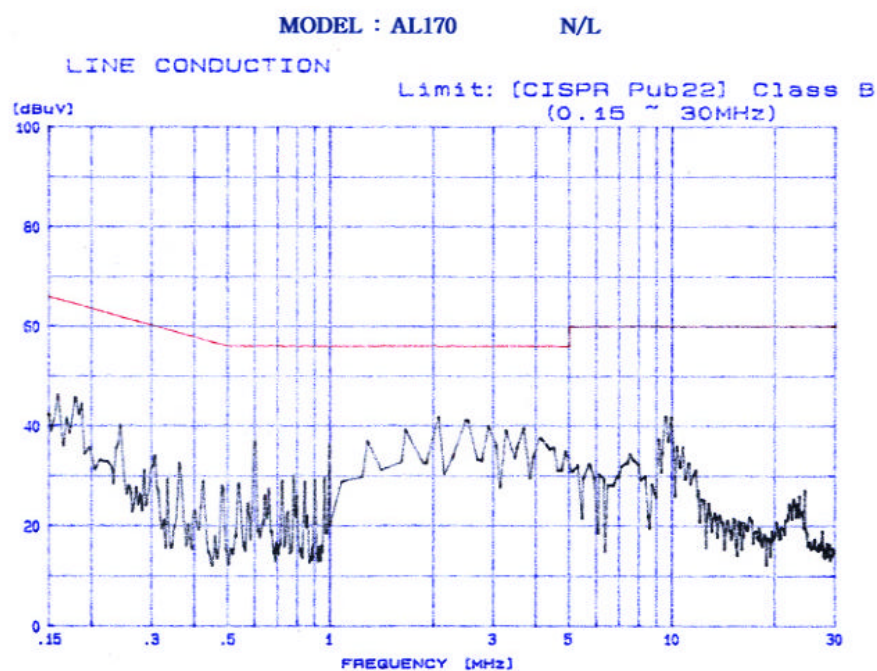
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2.1.10 Plots of Test Data

Polarization: HOT (LIVE)



Polarization: NEUTRAL



2.2 Radiated Emission Measurements

2.2.1 Test Description

The radiated emission measurements were performed in a Open Area Test Site (OATS), using the setup in accordance with ANSI C63.4-1992 radiated emission measurement procedure.

2.2.2 Test Equipments

Description	Manufacturer	Model Number	Serial Number	Cal. Due
Spectrum Analyzer	Hewlett Packard	8568B	3217A05629	08, 2003
Spectrum Display	Hewlett Packard	85682A	3144A20886	08, 2003
RF Preselector	Hewlett Packard	85685A	3221A01366	08, 2003
Quasi-Peak Adapter	Hewlett Packard	85650A	3145A01652	08, 2003
Biconical Antenna	Electro Metrics	BIA-30S	164	10, 2003
Log Periodic Antenna	Electro Metrics	LPA-30	387	10, 2003
Turn Table	KSQ	KSQ-T10	KSQ98121	n/a
Antenna Mast	KSQ	KSQ-A10	KSQ98122	n/a

2.2.3 Test Environments

Ambient Temperatures	Relative Humidity
15~35 °C	30~60 %

2.2.4 Test Limits

Frequency (MHz)	FCC Part 15 Limits			
	Class B @3m		Class A @10m	
	(dBuV/m)	(uV/m)	(dBuV/m)	(uV/m)
30 to 88	40.0	100	39.5	90
88 to 216	43.5	150	43.5	150
216 to 960	46.0	200	46.5	210
above 960	54.0	500	49.5	300

2.2.5 Test Exercise Program

The EUT test exercise program which generate a complete line of continuously repeating "H" pattern were used as the test program. The program sequentially exercises each system component by doing the following: 1) An "H" pattern is printed on the monitor; 2) Data is sent to the serial; 3) Printer prints a line of "H"s and; 4) Mass storage devices (HDD/CD-ROM) reads and writes the data. At the same time, Ethernet was executed "Network Neighborhood" to link with the remote server to receive and transmit data by UTP cable. The PS/2 keyboard and mouse were continuously scanned for data input activity during testing. The PC Camera were used to investigate USB port on the PC. This represents the worst-case configuration.

2.2.6 Test Procedure

Before final measurements of radiated emission were made on the OATS, the EUT was scanned in semi-anechoic chamber in order to determine its emission spectrum signature. The physical arrangement of the test system and associated cabling was varied in order to determine the effect on the EUT's emission in amplitude, direction and frequency. This process was repeated during final radiated emission measurements on the OATS range, at each frequency, in order to ensure that maximum emissions amplitudes were attained.

The radiated emission test was performed with EUT exercise program loaded, and the emissions were scanned between 30MHz to 1000MHz using a HP 8568B spectrum analyzer. The spectrum analyzer's 6dB bandwidth was set to 120kHz, and the analyzer was operated in the CISPR quasi-peak detection mode.

At each frequency, the EUT was rotated 360 degrees, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum emission levels. Measurements were taken using both HORIZONTAL and VERTICAL antenna polarization, herein referred to as H and V, respectively.

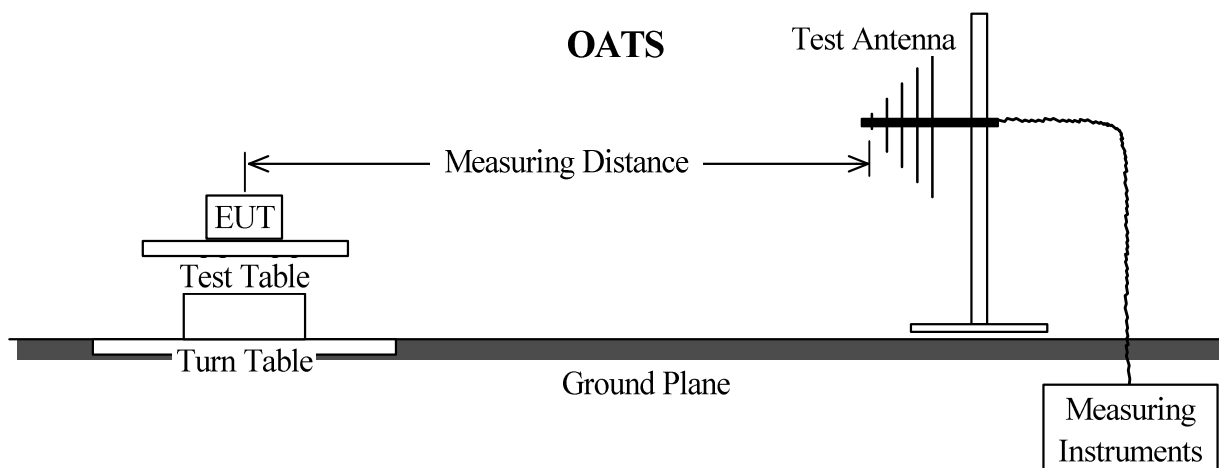
When any clock exceeds 108 MHz, the EUT was tested between 1 to 2 GHz in peak mode with the resolution bandwidth set at 1 MHz as stated in ANSI C63.4-1992. The highest emission amplitudes relative to the appropriate limit were measured and recorded in this report.

2.2.7 Field Strength Calculation

The Field Strength (FS) is calculated by adding the Antenna Factor (AF) and Cable Factor (CF) from the Measured Reading (MR). The basic equation with a sample calculation is as follows:

$$FS(dBuV/m) = MR(dBuV) + [AF(dB/m) + CF(dB)]$$

2.2.8 Test Configuration



EMI TEST REPORT



Report Number : KSQ-FCC030627

FCCID : PDLAL170

2.2.9 Test Results

According to the data in section 2.2.10, the EUT complied with the FCC Part 15 standards, and had the worst margin reading of:

-4.4dB at 850.46MHz in the VERTICAL antenna polarization.

2.2.10 Test Data

Indicated		Antenna		Correction Factor		Corrected Amplitude	FCC Part15 Class B		
Frequency (MHz)	Amplitude (dBuV/m)	Polar. (H/V)	Height (m)	Ant. (dB)	Cable (dB)	(dBuV/m)	Applicable (dBuV/m)	Limit (uV/m)	Margin (dB)
33.78	11.5	V	2.8	16.3	0.9	28.7	40.0	100	-11.3
43.44	19.4	V	2.8	11.8	1.1	32.3	40.0	100	-7.7
47.43	22.4	V	2.7	10.2	1.1	33.7	40.0	100	-6.3
63.46	25.7	H	3.5	6.1	1.4	33.2	40.0	100	-6.8
65.49	27.5	H	3.3	6.1	1.4	35.0	40.0	100	-5.0
79.56	23.0	H	3.3	8.0	1.5	32.5	40.0	100	-7.5
96.08	21.2	H	3.2	11.0	1.6	33.8	43.5	150	-9.7
103.64	20.6	H	2.8	12.0	1.7	34.3	43.5	150	-9.2
122.82	15.9	V	2.5	13.8	1.9	31.6	43.5	150	-11.9
135.00	20.7	V	2.5	14.6	2.1	37.4	43.5	150	-6.1
194.12	19.5	V	2.4	15.8	2.5	37.8	43.5	150	-5.7
202.28	18.9	V	2.4	15.8	2.6	37.3	43.5	150	-6.2
270.11	20.6	H	2.0	17.6	3.1	41.3	46.0	200	-4.7
454.64	20.1	H	1.8	16.3	4.3	40.7	46.0	200	-5.3
497.78	17.8	V	1.5	18.1	4.5	40.4	46.0	200	-5.6
522.19	18.8	V	1.2	17.9	4.7	41.4	46.0	200	-4.6
528.35	19.4	V	1.2	17.8	4.7	41.9	46.0	200	-4.1
668.26	16.2	V	1.0	20.3	5.4	41.9	46.0	200	-4.1
-	-	-	-	-	-	-	54.0	500	-

Temperature: 24 °C Humidity: 45 % Test Date: Jun 25, 2003 Tested by: Y. Choi